

# Search Notes



Application/Control No.

10/693,744

Examiner

John Kreck

Applicant(s)/Patent under Reexamination

BAI ET AL.

Art Unit

3673

## SEARCHED

Class	Subclass	Date	Examiner
166	302		
	57		
	59		
	60		
	61	11/24/06	JK

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
text	attached	11/27/06	JK

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
text search attached	12/21/2005	JK